Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10606879	STUYVER ET AL.
Examiner	Art Unit
BO DENG	16/18

	SEARCHED		
Class	Subclass	Date	Examine

SEARCH NOTES		
Search Notes	Date	Examiner
STIC SEQ ID NO:279, 280, 281, 282 and 283	8/7/08	BP
STIC:STN; East;Inventors: see score	8/7/08	BP
PuMed:see attached	8/20/08	BP

	INTERFERENCE SEAI	RCH	
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